Substitute Form PTO-1449
(Modified)U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
12406-003001Application No.
09/221,789
Information Disclosure Statement
by Applicant
 (Use several sheets if necessary)
Applicant
Ulrike Reeh et al.Filing Date
December 28, 1998Group Art Unit
2815**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AB	3,573,568	04/1971	Siegel			
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Examiner Signature

Date Considered

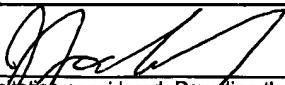
9/05

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U.S. Patent Documents							
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	BA						
	BB						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
<i>JW</i>	BC	1 007 825	10/31/1995	Belgium	E01F	G02B	Abstract Only
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Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
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	CJ	Möllmer et al., "Siemens SMT TOP-LED for Surface Mounting", <u>Siemens Components</u> , Bd. 26, No. 6, pp. 193-196 (1991)
	CK	Translation of Japanese Office Action Dated June 2, 2005
	CL	Notice of European Opposition Dated February 28, 2005
	CM	Six European Search Reports dated May 25, 2005
	CN	<i>In the Matter of Certain Light-Emitting Diodes and Products Containing Same</i> , Investigation No. 337-TA-512, "Notice of Commission Final Determination of No Violation of Section 337 as to One Patent and Determination to Remand the Investigation as Certain Other Patents," Dated August 10, 2005
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	CQ	
	CR	

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